L Number	Hits	Search Text	DB	Time stamp
1	1198	324/73.1.ccls.	USPAT; US-PGPUB; EPO; JPO;	2003/08/18 13:02
2	20029	nmos adj transistor	DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO;	2003/08/18 13:03
3	9640	data adj3 pin	DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT;	2003/08/18
4	, o	324/73.1.ccls. and (nmos adj transistor) and (data adj3 pin)	IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT;	2003/08/18 13:04
5	13	324/73.1.ccls. and (nmos adj transistor)	IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT;	2003/08/18 13:05
6	8	(324/73.1.ccls. and (nmos adj transistor)) and pin	IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT;	2003/08/18 13:05
7	5	((324/73.1.ccls. and (nmos adj transistor)) and pin) and data	IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT;	2003/08/18
8	398	(nmos adj transistor) and (data adj3 pin)	IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT;	2003/08/18
9	194	((nmos adj transistor) and (data adj3 pin)) and (test\$4 or measur\$6)with (mode or circuit)	IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT;	2003/08/18
10	. 32	<pre>((nmos adj transistor) and (data adj3 pin)) and(nmos with (test\$4 or measur\$6)with (mode or circuit))</pre>	IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/08/18